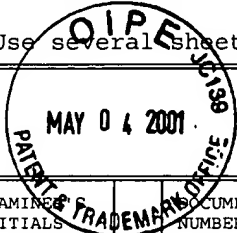


U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)	Atty. Docket No. 981117DS	Serial No. 09/441,805
	Applicant David F. Smith, et al.	
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U. S. PATENT DOCUMENTS

EXAMINER'S INITIALS	DOCUMENT NUMBER	ISSUE DATE	PATENTEE	CLASS	SUB-CLASS	FILING DATE
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FOREIGN PATENTS OR PUBLISHED FOREIGN PATENT APPLICATIONS

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EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.		

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